EESTI STANDARD

Fibre optic active components and devices - Test and measurement procedures - Part 6: Universal mezzanine boards for test and measurement of photonic devices



EESTI STANDARDI EESSÕNA

NATIONAL FOREWORD

See Eesti standard EVS-EN IEC 62150-6:2022 sisaldab Euroopa standardi EN IEC 62150-6:2022 ingliskeelset teksti.	This Estonian standard EVS-EN IEC 62150-6:2022 consists of the English text of the European standard EN IEC 62150-6:2022.	
Standard on jõustunud sellekohase teate avaldamisega EVS Teatajas	This standard has been endorsed with a notification published in the official bulletin of the Estonian Centre for Standardisation and Accreditation.	
Euroopa standardimisorganisatsioonid on teinud Euroopa standardi rahvuslikele liikmetele kättesaadavaks 11.03.2022.	Date of Availability of the European standard is 11.03.2022.	
Standard on kättesaadav Eesti Standardimis- ja Akrediteerimiskeskusest.	The standard is available from the Estonian Centre for Standardisation and Accreditation.	

Tagasisidet standardi sisu kohta on võimalik edastada, kasutades EVS-i veebilehel asuvat tagasiside vormi või saates e-kirja meiliaadressile <u>standardiosakond@evs.ee</u>.

ICS 33.180.20

Standardite reprodutseerimise ja levitamise õigus kuulub Eesti Standardimis- ja Akrediteerimiskeskusele

Andmete paljundamine, taastekitamine, kopeerimine, salvestamine elektroonsesse süsteemi või edastamine ükskõik millises vormis või millisel teel ilma Eesti Standardimis- ja Akrediteerimiskeskuse kirjaliku loata on keelatud.

Kui Teil on küsimusi standardite autoriõiguse kaitse kohta, võtke palun ühendust Eesti Standardimis- ja Akrediteerimiskeskusega: Koduleht www.evs.ee; telefon 605 5050; e-post info@evs.ee

The right to reproduce and distribute standards belongs to the Estonian Centre for Standardisation and Accreditation

No part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying, without a written permission from the Estonian Centre for Standardisation and Accreditation.

If you have any questions about standards copyright protection, please contact the Estonian Centre for Standardisation and Accreditation: Homepage www.evs.ee; phone +372 605 5050; e-mail info@evs.ee

EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

EN IEC 62150-6

March 2022

ICS 33.180.20

English Version

Fibre optic active components and devices - Test and measurement procedures - Part 6: Universal mezzanine boards for test and measurement of photonic devices (IEC 62150-6:2022)

Composants et dispositifs actifs fibroniques - Procédures d'essais de base et de mesures - Partie 6: Cartes mezzanines universelles pour les essais et les mesures des dispositifs photoniques (IEC 62150-6:2022)

Aktive Lichtwellenleiter-Bauteile und -Bauelemente - Prüfund Messverfahren - Teil 6: Universelle Mezzanine Platinen zur Prüfung und Messung von photonischen Baugruppen (IEC 62150-6:2022)

This European Standard was approved by CENELEC on 2022-03-04. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Croatia, Cyprus, the Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Republic of North Macedonia, Romania, Serbia, Slovakia, Slovenia, Spain, Sweden, Switzerland, Turkey and the United Kingdom.



European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

© 2022 CENELEC All rights of exploitation in any form and by any means reserved worldwide for CENELEC Members.

European foreword

The text of document 86C/1721/CDV, future edition 1 of IEC 62150-6, prepared by SC 86C "Fibre optic systems and active devices" of IEC/TC 86 "Fibre optics" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 62150-6:2022.

The following dates are fixed:

- latest date by which the document has to be implemented at national (dop) 2022-12-04 level by publication of an identical national standard or by endorsement
- latest date by which the national standards conflicting with the (dow) 2025-03-04 document have to be withdrawn

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CENELEC shall not be held responsible for identifying any or all such patent rights.

Any feedback and questions on this document should be directed to the users' national committee. A complete listing of these bodies can be found on the CENELEC website.

Endorsement notice

The text of the International Standard IEC 62150-6:2022 was approved by CENELEC as a European Standard without any modification.

2



IEC 62150-6

Edition 1.0 2022-01

INTERNATIONAL



Fibre optic active components and devices – Test and measurement procedures – Part 6: Universal mezzanine boards for test and measurement of photonic devices



THIS PUBLICATION IS COPYRIGHT PROTECTED Copyright © 2022 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

IEC Secretariat 3, rue de Varembé CH-1211 Geneva 20 Switzerland

Tel.: +41 22 919 02 11 info@iec.ch www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

IEC publications search - webstore.iec.ch/advsearchform

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee, ...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: sales@iec.ch.

IEC Products & Services Portal - products.iec.ch

Discover our powerful search engine and read freely all the publications previews. With a subscription you will always have access to up to date content tailored to your needs.

Electropedia - www.electropedia.org

The world's leading online dictionary on electrotechnology, containing more than 22 300 terminological entries in English and French, with equivalent terms in 19 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.



IEC 62150-6

Edition 1.0 2022-01

INTERNATIONAL STANDARD

en is



Fibre optic active components and devices – Test and measurement procedures – Part 6: Universal mezzanine boards for test and measurement of photonic devices

INTERNATIONAL ELECTROTECHNICAL COMMISSION



ICS 33.180.20

Warning! Make sure that you obtained this publication from an authorized distributor.

CONTENTS

FOREWO	ORD	3
INTROD	UCTION	5
1 Sco	ре	6
2 Norr	native references	6
3 Terr	ns and definitions	6
4 Mez	zanine board requirements	7
4 1	Functional description	7
4.2	Critical dimensions	9
4.3	Daughtercard and extended system	11
4.4	Power and signal flows	15
Annex A	(informative) International collaborative research and development	18
A.1	Overview	18
A.2	European FP7 PhoxTroT project	19
A.3	European H2020 Nephele project	19
A.4	European H2020 COSMICC project	19
A.5	Benefit of universal test board	20
Bibliogra	phy	21
Figure 1	– Outlines of mezzanine test boards	7
Figure 2	- Attachment of PDS onto M2 board	8
Figure 3	 Mezzanine board 1 (M1) – Relative positions of power and low speed signal 	
connecto	ors on top and bottom surfaces and mezzanine board origin	9
Figure 4 connecto	 Mezzanine board 2 (M2) – Relative positions of power and low speed signal ors on top and bottom surfaces and mezzanine board origin 	10
Figure 5 and low s	 Power distribution and sensor board (PDS) – Relative positions of power speed signal connectors on bottom surfaces and mezzanine board origin 	10
Figure 6 with elec	 Outline dimensions of extended double Eurocard form factor daughtercard trical edge connectors and cut-outs to accommodate optical backplane 	
connecto	ors	12
Figure 7	 Attachment of M2 boards onto daughtercard 	13
Figure 8 attached	 Extended double Eurocard form factor daughtercard with two M2 boards 	14
Figure 9 attached	 Extended double Eurocard form factor daughtercard with four M1 boards 	14
Figure 10 and one	0 – Extended double Eurocard form factor daughtercard with two M1 boards M2 board attached	15
Figure 1 ² between	1 – Functional diagram showing power and low speed signal distribution PDS, M1/M2, daughtercard and backplane	16
Figure 12 on a syst	2 – Multiple daughtercards populated with M1/M2 and PDS in multiple slots	17
Figure A	.1 – Example of cross-project deployment of mezzanine test card [3]	18
Figure A	2 – Examples of M2 test boards developed on EU H2020 COSMICC project	20
Table 1 -	- Critical relative dimensions	11
Table 2 -	- Voltages and low-power signal designations	16

INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIBRE OPTIC ACTIVE COMPONENTS AND DEVICES – TEST AND MEASUREMENT PROCEDURES –

Part 6: Universal mezzanine boards for test and measurement of photonic devices

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

IEC 62150-6 has been prepared by subcommittee SC 86C: Fibre optic systems and active devices of IEC technical committee 86: Fibre optics. It is an International Standard.

The text of this International Standard is based on the following documents:

Draft	Report on voting
86C/1721/CDV	86C/1752/RVC

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

A list of all parts in the IEC 62150 series, published under the general title *Fibre optic active components and devices – Test and measurement procedures*, can be found on the IEC website.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/publications.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- · replaced by a revised edition, or
- amended.

IMPORTANT – The "colour inside" logo on the cover page of this document indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

INTRODUCTION

This document defines a generic electro-optic mezzanine board for the test and measurement of micro-optical and micro-photonic devices, including a wide diversity of photonic integrated circuit (PIC) technologies including, but not limited to, transceivers, switches, sensors, neuromorphic networks, LiDAR and quantum integrated circuits. The board size and shape would allow two mezzanine boards to be mounted, side-by-side, on a larger Eurocard form factor daughtercard, which itself can be docked into and powered from a backplane system. Alternatively, each mezzanine board can be operated alone, for example on a lab bench powered from a bench supply.

The purpose of this generic mezzanine board concept is to allow like-for-like comparative characterisation of devices under test (DUTs) with respect to one another and to measure the performance of DUTs within larger test environments, relevant to their targeted application, such as data centre systems, high performance computers, automotive or 5G cabinets. The mezzanine board PCB will be designed to accommodate very high-speed electronic signals and a high-speed electronic signal interface to allow external test equipment such as test pattern generators, bit error rate testers and communication signal analysers to drive the device under test (DUT).

This approach will be instrumental in accelerating commercial adoption of micro-photonic devices as they will provide a common benchmark, against which to evaluate the true performance of a DUT. For example, power consumption is an increasingly important figure of merit for optical micro-transceivers in ICT systems; however, the declared values of power consumption as interpreted by the developer often do not reflect the true power consumption of a device under test in operation. The mezzanine board will therefore include provision for a smaller detachable power distribution and sensor mezzanine board allowing multiple tuneable voltages to be provided to the device under test and real-time current or power measurement for each voltage.

Variants of these mezzanine boards have been successfully developed and adopted within the European research and development projects European FP7 project PhoxTrot [1]¹, European H2020 Nephele [2] and European H2020 COSMICC [3]. Annex A provides an introduction to these projects.

¹ Numbers in square brackets refer to the Bibliography.

FIBRE OPTIC ACTIVE COMPONENTS AND DEVICES – TEST AND MEASUREMENT PROCEDURES –

Part 6: Universal mezzanine boards for test and measurement of photonic devices

1 Scope

This part of IEC 62150 specifies a generic mezzanine board system to support test and measurement of devices based on micro-optical and micro-photonic technologies, including but not limited to photonic integrated circuit (PIC) devices.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-731, International Electrotechnical Vocabulary – Part 731: Optical fibre communication (available at www.electropedia.org)

IEC 62150-1, Fibre optic active components and devices – Test and measurement procedures – Part 1: General and guidance

IEC TR 63072-1, Photonic integrated circuits – Part 1: Introduction and roadmap for standardization

3 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60050-731, IEC 62150-1, IEC TR 63072-1 and the following apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at http://www.electropedia.org/
- ISO Online browsing platform: available at http://www.iso.org/obp

3.1

mezzanine board

electronic, optical, or electro-optical printed circuit board designed to be docked onto a larger board such that the surfaces of the mezzanine board and larger board are parallel

3.2 photonic integrated circuit

PIC

integrated circuit that contains optical structures to guide and process optical signals

Note 1 to entry: See IEC TR 63072-1.